Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/633,449	SHARPE ET AL.	
Examiner	Art Unit	Τ
Sang Nguyen	2877	

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Class	Subclass	Date	Examiner
UP Date	Searched the same above	6/2/2006	SN
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INT	INTERFERENCE SEARCHED				
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as same	above	6/2/2006	SN		
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	DATE	EXMR
SEARCH Interference History Printed Out	6/2/2006	SN